PATENT APPLICATION

I hereby certify that this paper is being deposited

with the United States Postal Service as FIRST-

CLASS mail in an envelope addressed to:

Commissioner for Patents, P.O. Box 1450,

Registration No. 35,132

Attorney for Applicant(s)

Please Enter /SR/ 04/24/2008

Alexandria, VA 22313-1450, on this date.

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Yeshaiahu Fainman

Serial No.: 10/521,425

Conf. No.: 9057

Filed: 3/22/2005

For: HOLOGRAPHICALLY

DEFINED SURFACE MASK

ETCHING METHOD AND

ETCHED OPTICAL

STRUCTURES

Art Unit: 2814

Examiner: Rao, Shrinivas H.

Box AF

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

AMENE

\<u>\</u>L

December 20, 2007

Date

F-CLASS.WCM

Appr. February 20, 1998

Dear Sir:

Transmitted herewith is a communication regarding the above identified application.

Fee Calculation For Claims As Amended

	As Amended		Previously Paid For		Present Extra		Rate		Additional Fee	
Total Claims	21		21	_	0	_ x	\$ 50.00	=	\$	0
Independent Claims	3	-	3	_ =	0	_ x	\$210.00	=	\$	0
Fee for Multiple Dependent Claims							\$370.00	=	\$	0
Total Additional Fee							\$	0		
Small Entity Fee (reduced by half)								\$		

- (X) Response \underline{B} .
- (X) If a Petition under 37 C.F.R. §1.136(a) for an extension of time for response is required to make the attached response timely and does not separately accompany this transmittal, Applicant(s) hereby petition(s) under 37 C.F.R. §1.136(a) for an extension of time for response in the above-identified application for the period required to make the attached response timely.
- (X) The Commissioner is hereby authorized to charge any additional fees which may be required to this application under 37 C.F.R. §§1.16-1.17, or credit any overpayment, to Deposit Account No. 07-2069. A duplicate copy of this sheet is enclosed.

Respectfully submitted, December 20, 2007

300 South Wacker Drive – Suite 2500 Chicago, Illinois 60606

Tel.: (312) 360-0080 Fax: (312) 360-9315 Customer No.: 24978 GREER, BURNS & CRAIN, LTD.

By: Steven P. Fallon, Reg. No. 35,132



0321.68095

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Yeshaiahu Fainman

Serial No.:

10/521,425

Conf. No.:

9057

Filed:

3/22/2005

For:

HOLOGRAPHICALLY

DEFINED SURFACE MASK ETCHING METHOD AND

ETCHED OPTICAL

STRUCTURES

Art Unit:

2814

Examiner:

Rao, Shrinivas H.

I hereby certify that this paper is being deposited with the United States Postal Service as FIRST-CLASS mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on this date.

December 20, 2007

Date

F-CLASS.WCM

Appr. February 20, 1998

Registration No. 35,132
Attorney for Applicant(s)

RESPONSE B

Box AF Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

This is in response to the final Office Action mailed October 29, 2007.

REMARKS

As a first note, Applicants respectfully submit that the finality of the office action is inappropriate. The basis of the rejection against claim 20, originally §103 based upon Yoshimura and the examiner's official notice that "periodic defects (34) in the multilayer structure interrupting the alternating refracting indices with alternating periodically" was well known, has been apparently changed to relying upon a new combination of references that now includes Yoshimura and Visconti, where Visconti is relied upon for "the well known in the art the nanocavities". (See action p. 6). There was no mention in the original rejection of claim 20 of any reliance upon any "well known" features or anything that would give any impression whatsoever that Yoshimura was not